

Description

The AP10N012P uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

g DS

TO-220

General Features

 $V_{DS} = 100V I_D = 70A$

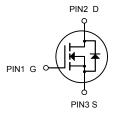
 $R_{DS(ON)}$ < 10.5m Ω @ V_{GS} =10V

Application

Battery protection

Load switch

Uninterruptible power supply



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
AP10N012P	TO-220	HXY MOSFET	50

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units	
VDS	Drain-Source Voltage	irce Voltage 100		
Vgs	Gate-Source Voltage	±20	V	
I _D	Continuous Drain CurrentTC=25 °C	70	А	
I _{DM}	PuledDrainCurrentnote1	entnote1 280		
EAS	Single Pulse Avalanche Energy ³	110	mJ	
P _D @T _C =25°C	Total Power Dissipation ⁴	100	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
R ₀ JA	Thermal Resistance Junction-Ambient ¹	64	°C/W	
R _θ Jc	R _θ Jc Thermal Resistance Junction-Ambient ¹		°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

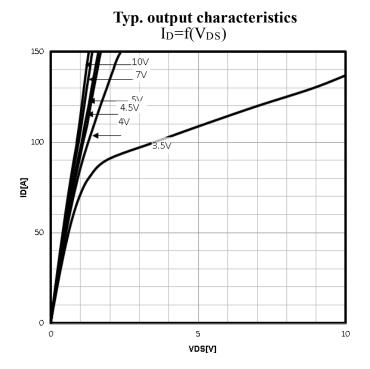
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			V	
2BVpss/2TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.098	1	V/°C	
_		V _{GS} =10V , I _D =20A		8.5	10.5	mΩ	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =15A		9.5	15	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage		1.0		2.5	V	
		V _{GS} =V _{DS} , I _D =250uA					
$\mathbb{P}V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	55 25, 5		-4.57		mV/°C	
		V _{DS} =80V , V _{GS} =0V , T _J =25°C			1	_	
loss	Drain-Source Leakage Current	V _{DS} =80V , V _{GS} =0V , T _J =55°C			5	uA	
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		0.48		Ω	
Qg	Total Gate Charge (10V)			31.3			
Qgs	Gate-Source Charge	V _{DS} =50V , V _{GS} =50V , I _D =10A		3.49		nC	
Qgd	Gate-Drain Charge			7.63			
Td(on)	Turn-On Delay Time			16		ns	
Tr	Rise Time	V _{DD} =50V , V _{GS} =10V , —R _G =4 O		10			
Td(off)	Turn-Off Delay Time	RG=4Ω I _D =10A		40	-		
T _f	Fall Time			6			
Ciss	Input Capacitance			1368			
Coss	Output Capacitance	V _{DS} =50V , V _{GS} =0V , f=1MHz		451		pF	
Crss	Reverse Transfer Capacitance			12.9			
ls	Continuous Source Current ^{1,5}				70	Α	
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			280	Α	
Vsp	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V	
trr	Reverse Recovery Time	IE-40A -11/34 400A/		103		nS	
Qrr	Reverse Recovery Charge	IF=10A , dl/dt=100A/μs , T _J =25°C		187		nC	

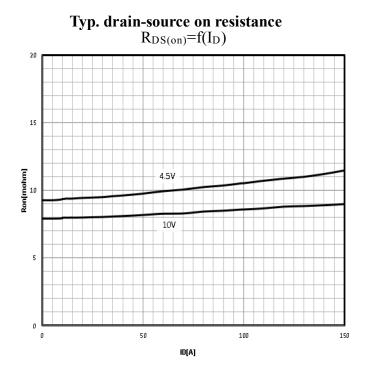
Note:

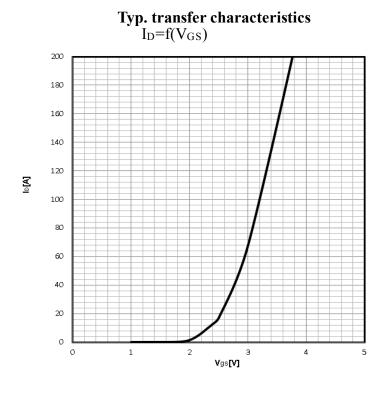
- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =11A
- 4.The power dissipation is limited by 150°C junction temperature
- 5 .The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

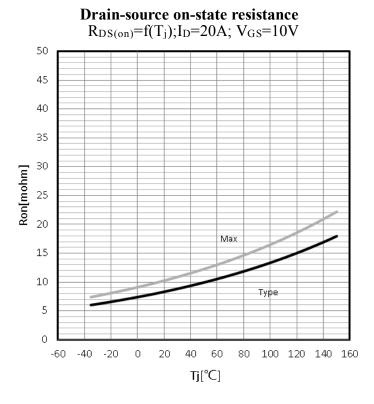


Typical Characteristics



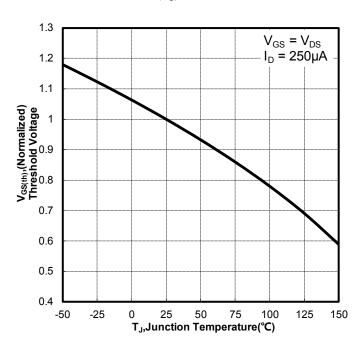




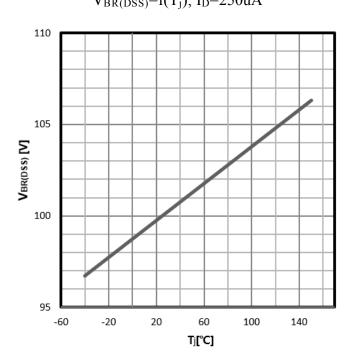




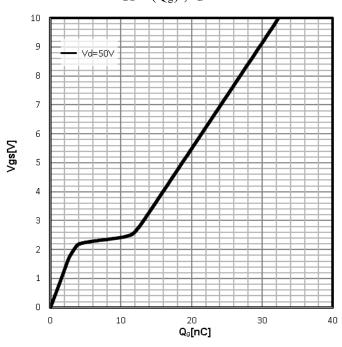
Gate Threshold Voltage V_{TH}=f(T_i); I_D=250uA



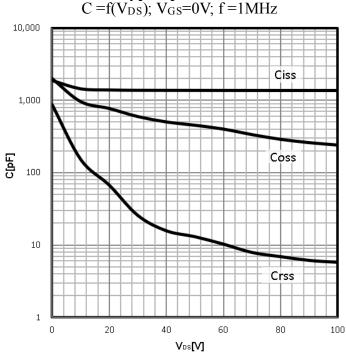
Drain-source breakdown voltage V_{BR(DSS)}=f(T_j); I_D=250uA



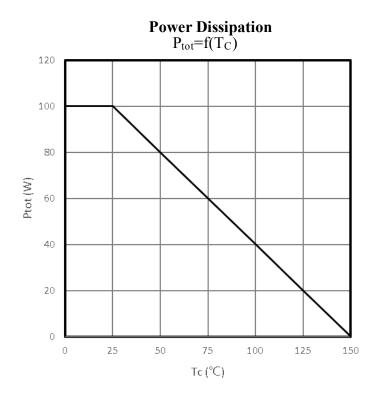
Typ. gate charge V_{GS} =f(Q_g) ; I_D =10A

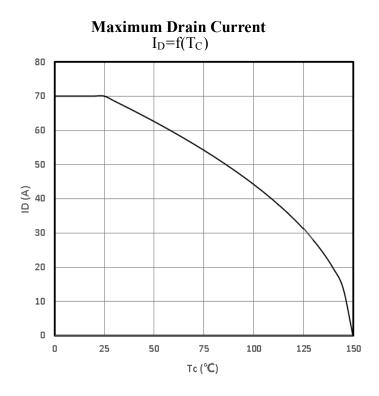


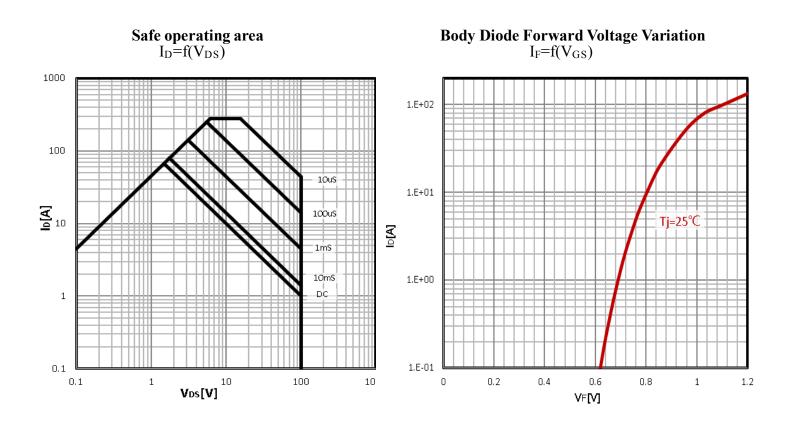
Typ. capacitances $C = f(V_{DS})$; $V_{GS} = 0V$; f = 1MHz

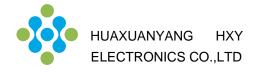






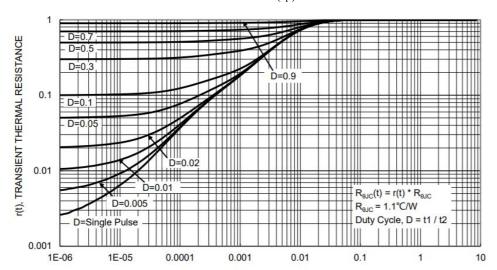






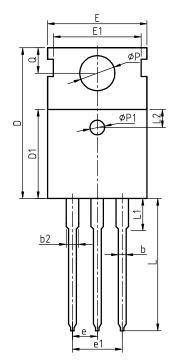
Max. transient thermal impedance

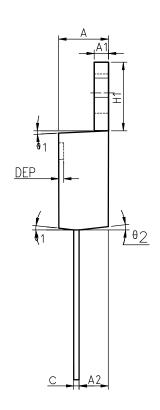






Package Information TO-220





COMMON DIMENSIONS



SYMBOL	MIN	NOM	MAX	MIN	NOM	MAX
Α	4.40	4.57	4.70	0.173	0.180	0. 185
A1	1.27	1.30	1.33	0.050	0.051	0.052
A2	2.35	2.40	2.50	0.093	0.094	0.098
b	0.77	0.80	0.90	0.030	0.031	0.035
b2	1.17	1.27	1.36	0.046	0.050	0.054
С	0.48	0.50	0.56	0.019	0.020	0.022
D	15.40	15.60	15.80	0.606	0.614	0.622
D1	9.00	9.10	9. 20	0.354	0.358	0.362
DEP	0.05	0.10	0.20	0.002	0.004	0.008
E	9.80	10.00	10.20	0.386	0.394	0.402
E1	-	8.70	-	-	0.343	-
E2	9.80	10.00	10.20	0.386	0.394	0.402
е		2.54	BSC		0.100	BSC
e1		5.08	BSC		0.200	BSC
H1	6.40	6.50	6.60	0. 252	0. 256	0.260
L	12.75	13.50	13.65	0.502	0.531	0.537
L1	-	3. 10	3.30	-	0.122	0.130
L2		2.50	REF		0.098	REF
Р	3.50	3.60	3.63	0.138	0.142	0.143
P1	3.50	3.60	3.63	0.138	0.142	0.143
Q	2.73	2.80	2.87	0.107	0.110	0.113
θ 1	5°	7°	9°	5°	7°	9°
θ 2	1°	3°	5°	1°	3°	5°
θ 3	1°	3°	5°	1°	3°	5°



Attention

- Any and all HUA XUAN YANG ELECTRONICS products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your HUA XUAN YANG ELECTRONICS representative nearest you before using any HUA XUAN YANG ELECTRONICS products described or contained herein in such applications.
- HUA XUAN YANG ELECTRONICS assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein.
- Specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- HUA XUAN YANG ELECTRONICS CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all HUA XUAN YANG ELECTRONICS products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of HUA XUAN YANG ELECTRONICS CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production.

 HUA XUAN YANG ELECTRONICS believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the HUA XUAN YANG ELECTRONICS product that you intend to use.